High Speed, High Gain Bipolar NPN Transistor with Antisaturation Network and Transient Voltage Suppression Capability

The BUD42D is a state-of-the-art bipolar transistor. Tight dynamic characteristics and lot to lot minimum spread make it ideally suitable for light ballast applications.

Features

- Free-Wheeling Diode Built-In
- Flat DC Current Gain
- Fast Switching Times and Tight Distribution
- "6 Sigma" Process Providing Tight and Reproducible Parameter Spreads
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Machine Model, C; >400 V Human Body Model, 3B; >8000 V
- Pb-Free Packages are Available

Two Versions

- BUD42D-1: Case 369D for Insertion Mode
- BUD42D, BUD42DT4: Case 369C for Surface Mount Mode

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Sustaining Voltage	V_{CEO}	350	Vdc
Collector-Base Breakdown Voltage	V_{CBO}	650	Vdc
Collector-Emitter Breakdown Voltage	V _{CES}	650	Vdc
Emitter-Base Voltage	V _{EBO}	9	Vdc
Collector Current - Continuous - Peak (Note 1)	I _C I _{CM}	4.0 8.0	Adc
Base Current - Continuous - Peak (Note 1)	I _B I _{BM}	1.0 2.0	Adc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	25 0.2	W W/°C
Operating and Storage Temperature	T _J , T _{stg}	-65 to +150	°C

TYPICAL GAIN

Typical Gain @ I _C = 1 A, V _{CF} = 2 V	hee	13	_
Typical Gain @ I _C = 1.A, V _{CE} = 2.V	h _{FE}	16	_

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

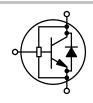
1. Pulse Test: Pulse Width = 5.0 ms, Duty Cycle = 10%10



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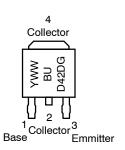
http://onsemi.com

4 AMPERES 650 VOLTS, 25 WATTS POWER TRANSISTOR

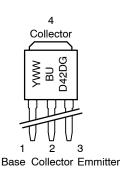


MARKING DIAGRAMS









Y = Year

WW = Work Week

BUD43D = Device Code

G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 10 of this data sheet.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	5.0	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	71.4	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8 in from Case for 5 seconds	TL	260	°C

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic				Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS								•
Collector-Emitter Sustaining Voltage (I _C = 100 mA, L = 25 mH)				V _{CEO(sus)}	350	430	_	Vdc
Collector-Base Breakdown (I _{CBO} = 1 mA)	Voltage			V _{CBO}	650	780	-	Vdc
Emitter-Base Breakdown Vo (I _{EBO} = 1 mA)	oltage			V _{EBO}	9.0	12	-	Vdc
Collector Cutoff Current (V_{CE} = Rated V_{CEO} , I_B = 0	0)		@ T _C = 25°C @ T _C = 125°C	I _{CEO}	- -	-	100 200	μAdc
Collector Cutoff Current (V _{CE} = Rated V _{CES} , V _{EB} = 0))		@ T _C = 25°C @ T _C = 125°C	I _{CES}	- -	- -	10 200	μAdc
Emitter-Cutoff Current (V _{EB} = 9 Vdc, I _C = 0)				I _{EBO}	-	-	100	μAdc
ON CHARACTERISTICS								
Base–Emitter Saturation Vol (I _C = 1 Adc, I _B = 0.2 Adc)	tage			V _{BE(sat)}	-	0.85	1.2	Vdc
Collector-Emitter Saturation (I _C = 2 Adc, I _B = 0.5 Adc)	Voltage			V _{CE(sat)}	-	0.2	1.0	Vdc
DC Current Gain $(I_C = 1 \text{ Adc, } V_{CE} = 2 \text{ Vdc})$ $(I_C = 2 \text{ Adc, } V_{CE} = 5 \text{ Vdc})$			h _{FE}	8.0 10	13 12	_	_	
DIODE CHARACTERISTICS								
Forward Diode Voltage (I _{EC} = 1.0 Adc)				V _{EC}	-	0.9	1.5	V
SWITCHING CHARACTERIS	TICS: Resistive Loa	d (D.C.≤ 10%	ն, Pulse Width = 40 լ	us)				
Turn–Off Time ($I_C = 1.2$ Adc, $I_{B1} = 0.4$ A, $I_{B2} = 0.1$ A, $V_{CC} = 300$ V)			T _{off}	4.6	-	6.55	μs	
Fall Time ($I_C = 2.5 \text{ Adc}, I_{B1} = I_{B2} = 0.5 \text{ A}, V_{CC} = 150 \text{ V}, V_{BE} = -2 \text{ V}$)			T _f	-	-	0.8	μs	
DYNAMIC SATURATION VO	LTAGE							
Dynamic Saturation Voltage: Determined 1 µs and 3 µs respectively after rising I _{B1} reaches 90% of final I _{B1}	I _C = 400 mA	@ 1 μs	@ T _C = 25°C @ T _C = 125°C	V _{CE(dsat)}	- -	2.8 3.2	- -	٧
	I _{B1} = 40 mA V _{CC} = 300 V	@ 3 μs	@ T _C = 25°C @ T _C = 125°C		- -	0.75 1.3	-	
	I _C = 1 A	@ 1 μs	@ T _C = 25°C @ T _C = 125°C		- -	2.1 4.7	- -	1
	$I_{B1} = 200 \text{ mA}$ $V_{CC} = 300 \text{ V}$	@ 3 μs	@ T _C = 25°C @ T _C = 125°C		-	0.35 0.6	-	1

TYPICAL STATIC CHARACTERISTICS

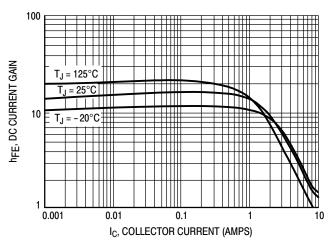


Figure 1. DC Current Gain @ $V_{CE} = 1 V$

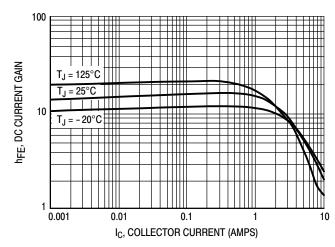


Figure 2. DC Current Gain @ V_{CE} = 5 V

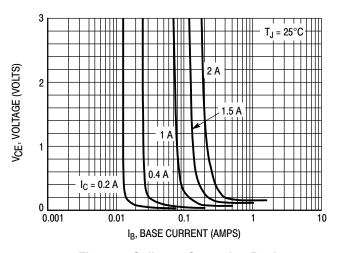


Figure 3. Collector Saturation Region

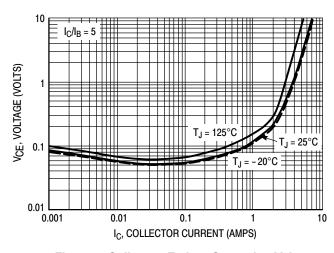


Figure 4. Collector-Emitter Saturation Voltage

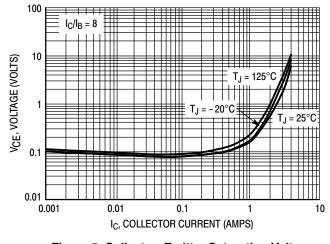


Figure 5. Collector-Emitter Saturation Voltage

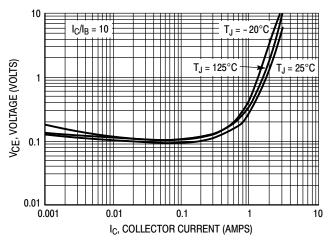


Figure 6. Collector-Emitter Saturation Voltage

TYPICAL STATIC CHARACTERISTICS

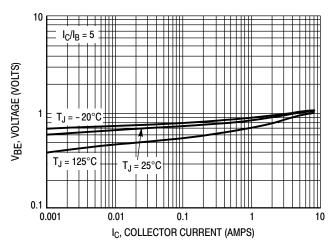


Figure 7. Base-Emitter Saturation Region

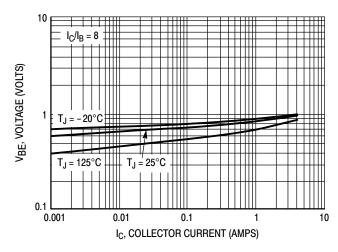


Figure 8. Base-Emitter Saturation Region

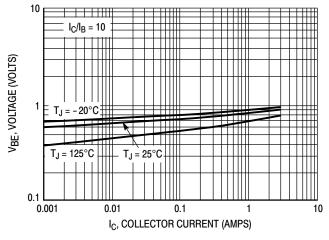


Figure 9. Base-Emitter Saturation Region

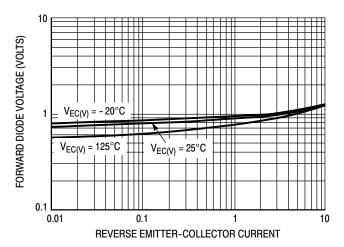


Figure 10. Forward Diode Voltage

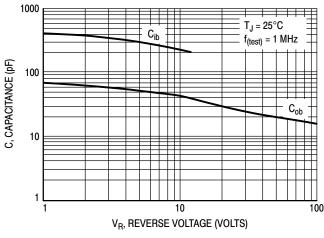


Figure 11. Capacitance

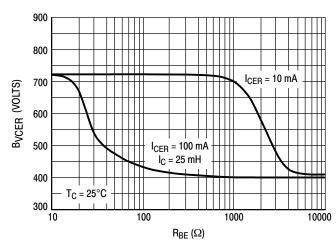


Figure 12. $B_{VCER} = f(R_{BE})$

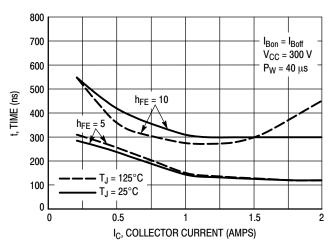


Figure 13. Resistive Switching, ton

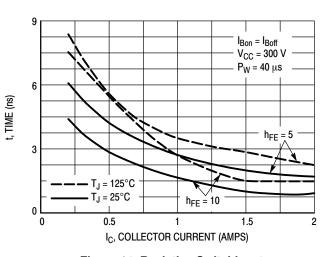


Figure 14. Resistive Switching, toff

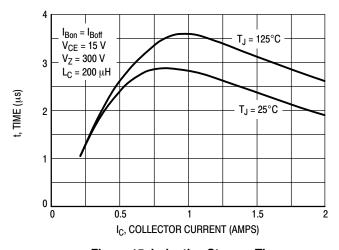


Figure 15. Inductive Storage Time, t_{ei} @ h_{FF} = 5

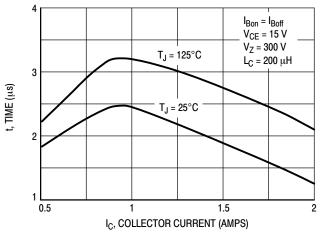


Figure 16. Inductive Storage Time, $t_{ei} @ h_{EE} = 10$

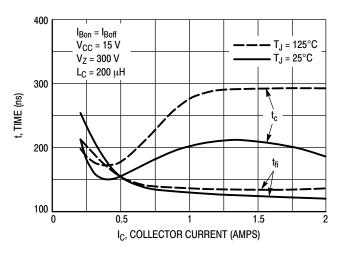


Figure 17. Inductive Fall and Cross Over Time, t_{fi} and $t_{c}\ @\ h_{FE}$ = 5

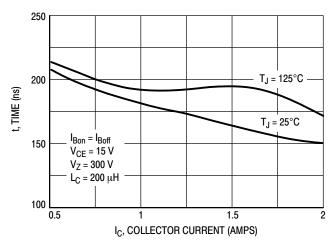


Figure 18. Inductive Fall Time, t_{fi} @ $h_{FE} = 10$

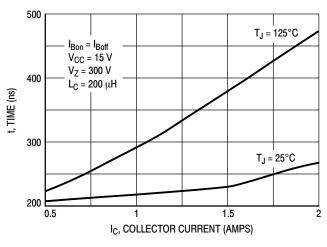


Figure 19. Inductive Cross Over Time, $t_{\text{C}} \ @ \ h_{\text{FE}} = 10$

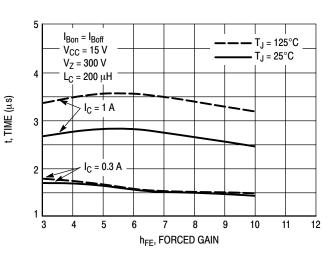


Figure 20. Inductive Storage Time, tsi

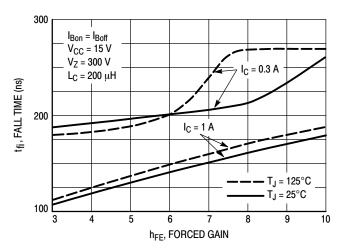


Figure 21. Inductive Fall Time, tf

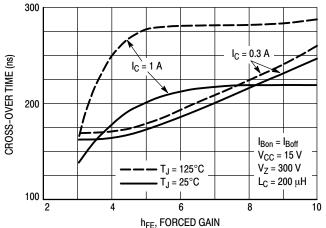


Figure 22. Inductive Cross Over Time, tc

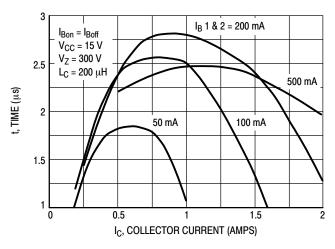


Figure 23. Inductive Storage Time, t_{si}

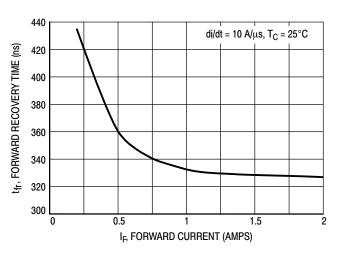


Figure 24. Forward Recovery Time, t_{fr}

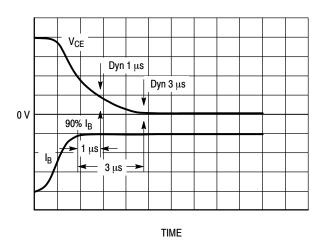


Figure 25. Dynamic Saturation Voltage Measurements

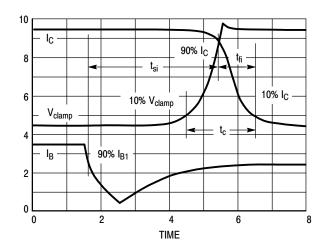
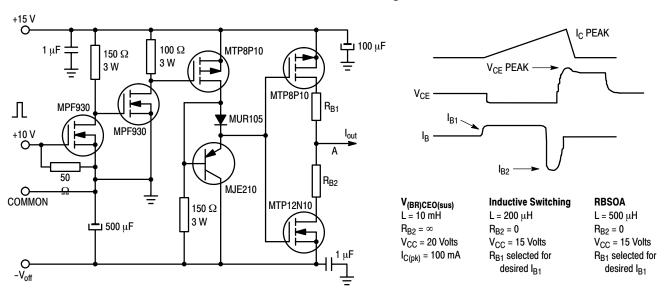


Figure 26. Inductive Switching Measurements

Table 1. Inductive Load Switching Drive Circuit



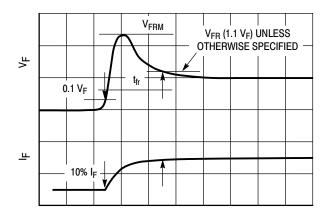


Figure 27. t_{fr} Measurement

MAXIMUM RATINGS

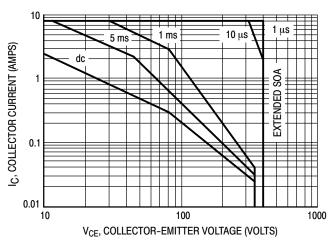


Figure 28. Forward Bias Safe Operating Area

Figure 29. Reverse Bias Safe Operating Area

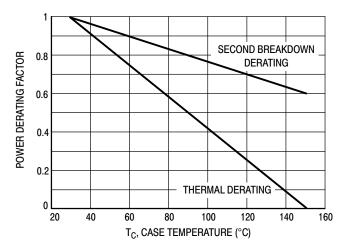


Figure 30. Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C – V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 28 is based on T_C = 25°C; $T_{j(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when T_C > 25°C. Second Breakdown limitations do not derate like thermal limitations. Allowable current at the voltages shown on

Figure 28 may be found at any case temperature by using the appropriate curve on Figure 30.

 $T_{j(pk)}$ may be calculated from the data in Figure 31. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn—off with the base to emitter junction reverse biased. The safe level is specified as reverse biased safe operating area (Figure 29). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

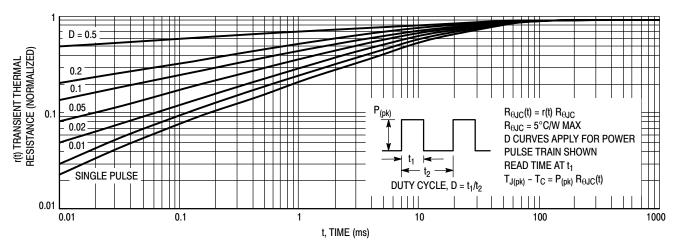


Figure 31. Thermal Response

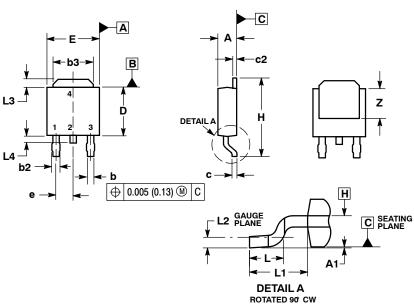
ORDERING INFORMATION

Device	Package	Shipping [†]
BUD42D	DPAK	75 Units / Rail
BUD42DG	DPAK (Pb-Free)	75 Units / Rail
BUD42D-1	DPAK Straight Lead	75 Units / Rail
BUD42D-1G	DPAK Straight Lead (Pb-Free)	75 Units / Rail
BUD42DT4	DPAK	2500 Units / Tape & Reel
BUD42DT4G	DPAK (Pb-Free)	2500 Units / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK CASE 369C-01 ISSUE D



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
- 2. CONTHOLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

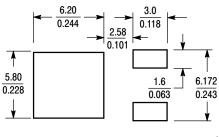
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIN	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR

SOLDERING FOOTPRINT*

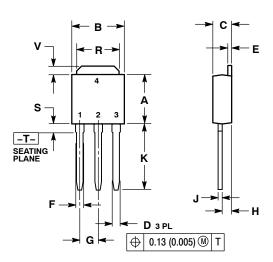


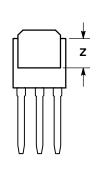
SCALE 3:1

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

DPAK STRAIGHT LEAD CASE 369D-01 **ISSUE B**





NOTES:

- 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	0.090 BSC		BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
Κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
7	0 155		3 93	

- STYLE 1:
 PIN 1. BASE
 2. COLLECTOR
 3. EMITTER
 4. COLLECTOR

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